

# **MOSFET** – N-Channel, POWERTRENCH®, **DUAL COOL® 88**

150 V, 99 A, 6.5 m $\Omega$ 

# **FDMT800150DC**

## **General Description**

This N-Channel MOSFET is produced using onsemi's advanced POWERTRENCH process. Advancements in both silicon and DUAL COOL package technologies have been combined to offer the lowest r<sub>DS(on)</sub> while maintaining excellent switching performance by extremely low Junction-to-Ambient thermal resistance.

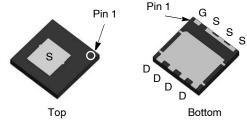
#### **Features**

- Max  $r_{DS(on)} = 6.5 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 15 \text{ A}$
- Max  $r_{DS(on)} = 8.4 \text{ m}\Omega$  at  $V_{GS} = 8 \text{ V}$ ,  $I_D = 13 \text{ A}$
- Advanced Package and Silicon Combination for Low r<sub>DS(on)</sub> and High Efficiency
- Next Generation Enhanced Body Diode Technology, Engineered for Soft Recovery
- Low Profile 8x8 mm MLP Package
- MSL1 Robust Package Design
- 100% UIL Tested
- This Device is Pb-Free, Halide Free and RoHS Compliant

#### **Applications**

- OringFET / Load Switching
- Synchronous Rectification
- DC-DC Conversion

V <sub>DS</sub>	r <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
150 V	6.5 mΩ @ 10 V	99 A
	8.4 mΩ @ 6 V	



**PQFN8 8X8, 2P** (Dual Cool 88) CASE 483AQ

#### **MARKING DIAGRAM**



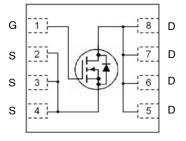
5G = Device Code

= Assembly Plant Code

YW = Date Code Z

= Traceability Code

## **ELECTRICAL CONNECTION**



**N-Channel MOSFET** 

#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information on page 7 of this data sheet.

## **MOSFET MAXIMUM RATINGS** ( $T_A = 25$ °C unless otherwise noted)

Symbol	Parameter				Rating	Unit
$V_{DS}$	Drain to Source Voltage				150	V
$V_{GS}$	Gate to Source V	/oltage			±20	V
I <sub>D</sub>	Drain Current	<ul><li>Continuous</li></ul>	T <sub>C</sub> = 25°C	(Note 5)	99	Α
		<ul><li>Continuous</li></ul>	T <sub>C</sub> = 100°C	(Note 5)	62	
		<ul><li>Continuous</li></ul>	T <sub>A</sub> = 25°C	(Note 1a)	15	
		- Pulsed		(Note 4)	561	
E <sub>AS</sub>	Single Pulse Ava	lanche Energy		(Note 3)	1093	mJ
$P_{D}$	Power Dissipatio	n	T <sub>C</sub> = 25°C		156	W
	Power Dissipatio	n	T <sub>A</sub> = 25°C	(Note 1a)	3.2	
T <sub>J</sub> , T <sub>STG</sub>	Operating and St	torage Junction Temper	ature Range		-55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

## THERMAL CHARACTERISTICS

Symbol	Parameter		Ratings	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Top Source)	1.6	°C/W
$R_{ heta JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	0.8	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	38	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	81	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1i)	15	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	21	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1k)	9	

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
OFF CHAP	RACTERISTICS				•	
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu\text{A},  V_{GS}  = 0  V$	150	_	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, referenced to 25°C	-	110	-	mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 120 V, V <sub>GS</sub> = 0 V	-	_	1	μΑ
I <sub>GSS</sub>	Gate to Source Leakage Current	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V	-	_	100	nA
ON CHAR	ACTERISTICS					
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2.0	3.0	4.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, referenced to 25°C	-	-12	-	mV/°C
r <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 15 A	-	5.4	6.5	mΩ
		V <sub>GS</sub> = 6 V, I <sub>D</sub> = 13 A	-	6.6	8.4	
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 15 A, T <sub>J</sub> = 125°C	-	11	13	
9FS	Forward Transconductance	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 15 A	-	48	_	S
DYNAMIC	CHARACTERISTICS					
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 75 V, V <sub>GS</sub> = 0 V, f = 1 MHz	-	5860	8205	pF
C <sub>oss</sub>	Output Capacitance		-	520	730	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		-	17	30	pF
$R_g$	Gate Resistance		0.1	1.4	3.5	Ω
SWITCHIN	IG CHARACTERISTICS					
td <sub>(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> = 75 V, I <sub>D</sub> = 15 A,	-	31	50	ns
t <sub>r</sub>	Rise Time	$V_{GS}$ = 10 V, $R_{GEN}$ = 6 $\Omega$	-	16	29	ns
t <sub>d(off)</sub>	Turn-Off Delay Time		-	41	66	ns
t <sub>f</sub>	Fall Time		-	9.3	19	ns
Q <sub>g(TOT)</sub>	Total Gate Charge	V <sub>GS</sub> = 0 V to 10 V, V <sub>DD</sub> = 75 V, I <sub>D</sub> = 15 A	-	77	108	nC
		V <sub>GS</sub> = 0 V to 6 V, V <sub>DD</sub> = 75 V, I <sub>D</sub> = 15 A	-	49	69	
Q <sub>gs</sub>	Gate to Source Charge	V <sub>DD</sub> = 75 V, I <sub>D</sub> = 15 A	-	25	-	nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge	1	-	14	_	nC
DRAIN-SC	DURCE DIODE CHARACTERISTICS					
$V_{SD}$	Source to Drain Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 2.9 A (Note 2)	-	0.7	1.1	V
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 15 A (Note 2)	-	0.8	1.2	
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 15 A, di/dt = 100 A/μs	-	103	165	ns
Q <sub>rr</sub>	Reverse Recovery Charge	1	-	233	373	nC

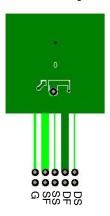
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### THERMAL CHARACTERISTICS

Symbol	Parameter		Ratings	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case	(Top Source)	1.6	°C/W
$R_{ heta JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	0.8	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	38	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	81	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1c)	26	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1d)	34	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1e)	14	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1f)	16	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1g)	26	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1h)	60	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1i)	15	
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	21	
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient	(Note 1k)	9	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1I)	11	

#### NOTES:

 R<sub>θ,JA</sub> is determined with the device mounted on a FR-4 board using a specified pad of 2 oz copper as shown below. R<sub>θ,CA</sub> is determined by the user's board design.



a) 38°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.



b) 81°C/W when mounted on a minimum pad of 2 oz copper.

- c) Still air, 20.9 x 0.4 x 2.7 mm Aluminum Heat Sink, 1 in 2 pad of 2 oz copper
- d) Still air, 20.9 x ] 0.4 x ] 2.7 mm Aluminum Heat Sink, minimum pad of 2 oz copper
- e) Still air, 45.2 x[]1.4 x[]1.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- f) Still air, 45.2 x 41.4 x 11.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper
- g) 200FPM Airflow, No Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- h) 200FPM Airflow, No Heat Sink, minimum pad of 2 oz copper
- i) 200FPM Airflow, 20.9 x[] 0.4 x[] 2.7 mm Aluminum Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- j) 200FPM Airflow, 20.9 x ] 0.4 x ] 2.7 mm Aluminum Heat Sink, minimum pad of 2 oz copper
- k) 200FPM Airflow, 45.2 x 4.1.4 x 1.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in 2 pad of 2 oz copper
- I) 200FPM Airflow, 45.2 x 1.1.4 x 1.1.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper
- 2. Pulse Test: Pulse Width < 300  $\mu$ s, Duty cycle < 2.0%.
- 3.  $E_{AS}$  of 1093 mJ is based on starting  $T_J = 25$  °C; N-ch: L = 3 mH,  $I_{AS} = 27$  A,  $V_{DD} = 150$  V,  $V_{GS} = 10$  V. 100% test at L = 0.1 mH,  $I_{AS} = 86$  A.
- 4. Pulsed Id please refer to Figure 11 SOA graph for more details.
- 5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

## TYPICAL CHARACTERISTICS (T<sub>J</sub> = 25°C UNLESS OTHERWISE NOTED)

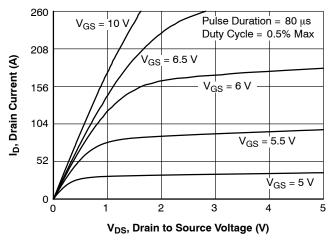


Figure 1. On-Region Characteristics

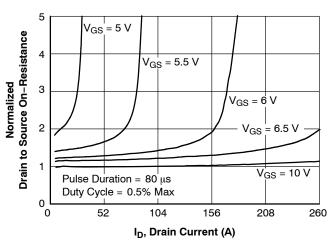


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

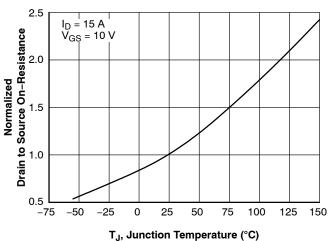


Figure 3. Normalized On-Resistance vs. Junction Temperature

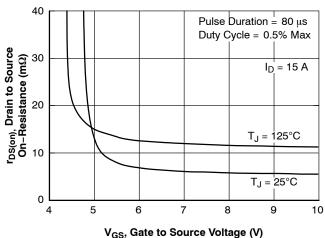


Figure 4. On-Resistance vs. Gate to Source Voltage

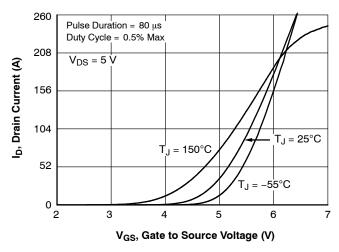


Figure 5. Transfer Characteristics

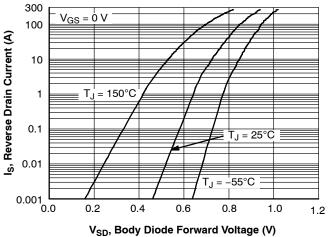


Figure 6. Source to Drain Diode Forward Voltage

vs. Source Current

## TYPICAL CHARACTERISTICS (T<sub>J</sub> = 25°C UNLESS OTHERWISE NOTED) (CONTINUED)

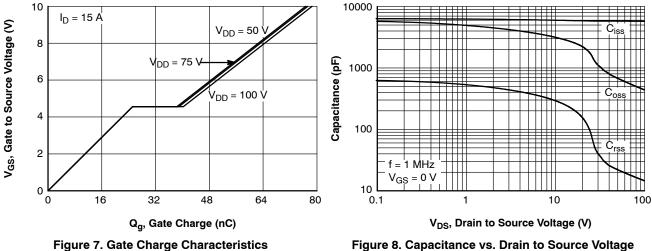


Figure 7. Gate Charge Characteristics

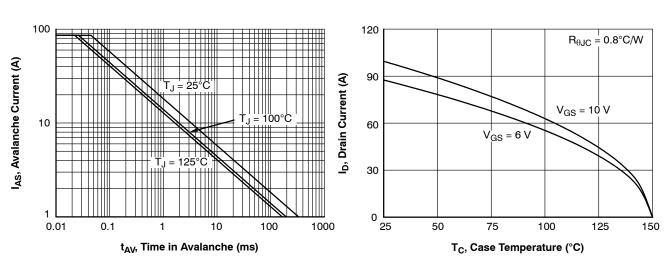


Figure 9. Unclamped Inductive Switching Capability

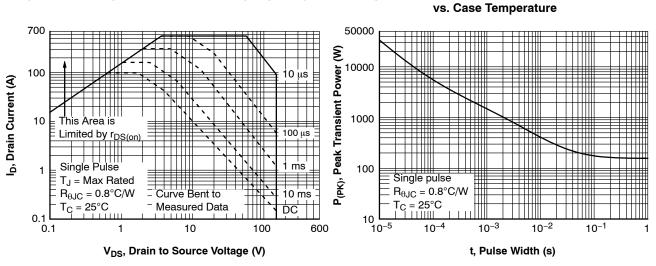


Figure 11. Forward Bias Safe Operating Area

Figure 12. Single Pulse Maximum Power Dissipation

Figure 10. Maximum Continuous Drain Current

## TYPICAL CHARACTERISTICS (T<sub>J</sub> = 25°C UNLESS OTHERWISE NOTED) (CONTINUED)

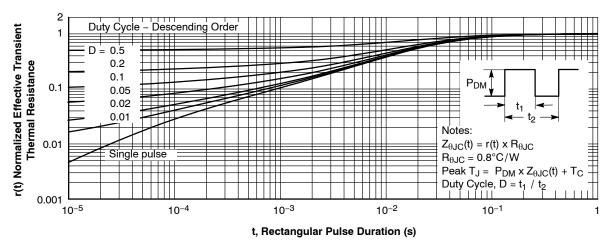


Figure 13. Junction-to-Case Transient Thermal Response Curve

#### PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Package	Reel Size	Tape Width	Shipping <sup>†</sup>
800150DC	FDMT800150DC	PQFN8 8X8, 2P, DUAL COOL 88		13.3 mm	3000 / Tape & Reel

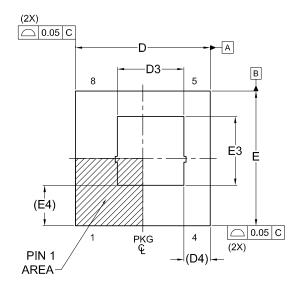
<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, <a href="https://example.com/BRD8011/D">BRD8011/D</a>.

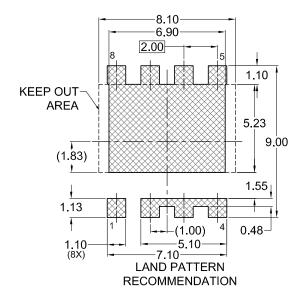




PQFN8 8X8, 2P CASE 483AQ ISSUE B

**DATE 24 OCT 2022** 



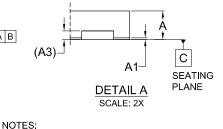


TOP VIEW

SEE DETAIL A

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRW/D.

## FRONT VIEW 0.10M C A B e1 05(M) C е b (8X) (8X) -(L1) PIN #1 IDENT e2 E5 E2 e3 (4X) E6 (z)(4X)D2 **BOTTOM VIEW**



1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.

- 2. CONTROLLING DIMENSION: MILLIMETERS
- COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- 4. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.
- 6. IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.

DIM	MILLIMETERS				
Diw	MIN.	NOM.	MAX.		
Α	0.75 0.85		0.95		
A1	0.00	-	0.05		
A3	(	).25 REF	:		
b	0.90	1.00	1.10		
D	7.90	8.00	8.10		
D2	6.80	6.90	7.00		
D3	3.68	3.86	4.03		
D4		1.56 REF			
Е	7.90 8.00 8.1				
E2	5.13	5.23	5.33		
E3	3.99	4.09	4.19		
E4	2.41 REF				
E5	-	0.35 REF			
E6		0.60 REF	:		
е	- 2	2.00 BSC	;		
e1	•	3.00 BSC	;		
e2	1.20 BSC				
<b>e</b> 3	2.78 BSC				
k	1.48 1.58 1.68				
L	0.50	0.60	0.70		
L1	0.20 REF				
z	0.50 REF				

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